## Notice of References Cited Application/Control No. 10/543,057 Examiner David W. Scheuermann U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination OTAKI ET AL. Art Unit Page 1 of 1

## Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-В US-С US-D US-US-Ε F US-G US-US-Н 1 US-J US-Κ US-US-L US-М

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP361070269A	11-1986	Japan	Tsukamoto et al.	
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